

<b>Notice of References Cited</b>	Application/Control No. 10/537,590	Applicant(s)/Patent Under Reexamination LIU ET AL.	
	Examiner Kenan Cehic	Art Unit 2616	Page 1 of 2

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	Examiner Kenan Cehic	Art Unit 2616	Page 2 of 2

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	K	US-			
	L	US-			
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